

**TC74VHC299F, TC74VHC299FW, TC74VHC299FT**

**8-BIT PIPO SHIFT REGISTER WITH ASYNCHRONOUS CLEAR**

(Note) The JEDEC SOP (FW) is not available in Japan.

The TC74VHC299 is an advanced high speed CMOS 8-BIT PIPO SHIFT REGISTER fabricated with silicon gate C<sup>2</sup>MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

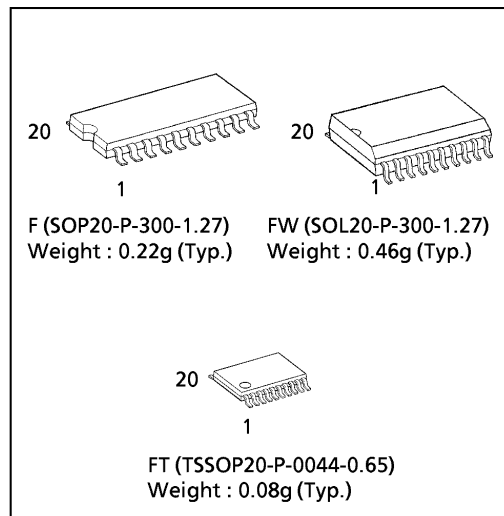
It has a four modes (HOLD, SHIFT LEFT, SHIFT RIGHT and LOAD DATA) controlled by the two selection inputs (S0, S1).

When one or both enable ( $\overline{G1}$ ,  $\overline{G2}$ ) are high, the eight I/O are forced to the high-impedance state; however, sequential operation or clearing of the register is not affected.

All inputs are equipped with protection circuits against static discharge.

**FEATURES :**

- High Speed..... $f_{MAX} = 160\text{MHz}(\text{typ.})$   
at  $V_{CC} = 5\text{V}$
- Low Power Dissipation..... $I_{CC} = 4\mu\text{A}(\text{Max.})$  at  $T_a = 25^\circ\text{C}$
- High Noise Immunity ..... $V_{NIH} = V_{NIL} = 28\%V_{CC}$  (Min.)
- Balanced Propagation Delays..... $t_{pLH} \approx t_{pHL}$
- Wide Operating Voltage Range  
..... $V_{CC}(\text{opr}) = 2\text{V} \sim 5.5\text{V}$
- Low Noise ..... $V_{OLP} = 1.4\text{V}(\text{Max.})$
- Pin and Function Compatible with 74ALS299



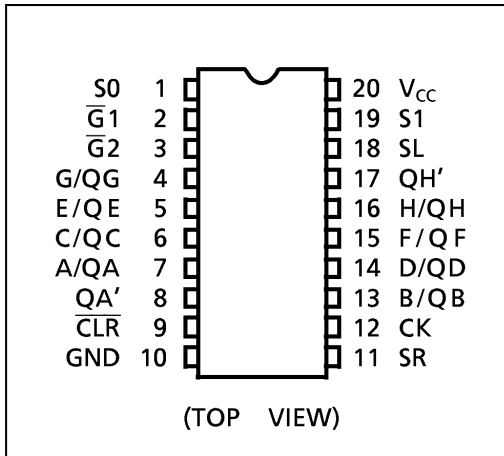
**APPLICATION NOTE**

- 1) Do not apply a signal to A / QA~H / QH bus terminal when it is in the output mode. Damage may result.
- 2) All floating (high impedance) A / QA~H / QH bus terminals must have their input levels fixed by means of pull up or pull down resistors.
- 3) A parasitic diode is formed between A / QA~H / QH bus and V<sub>CC</sub> terminals. Therefore bus terminal can not be used to interface 5V to 3V systems directly.

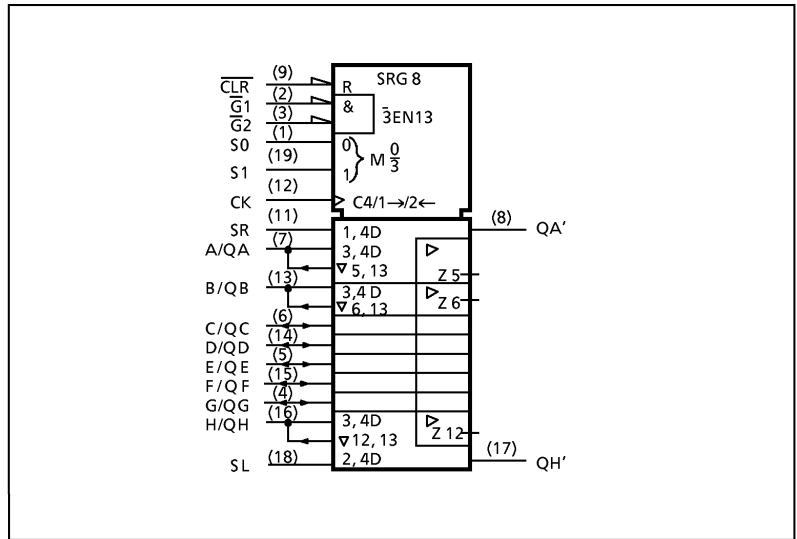
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PIN ASSIGNMENT



IEC LOGIC SYMBOL



TRUTH TABLE

MODE	INPUTS								INPUTS/OUTPUTS		OUTPUTS	
	$\overline{CLR}$	FUNCTION SELECT		OUTPUT CONTROL		CK	SERIAL		A/QA	H/QH	QA'	QH'
		S1	S0	$\overline{G1}^*$	$\overline{G2}^*$		SL	SR				
Z	L	H	H	X	X	X	X	X	Z	Z	L	L
CLEAR	L	L	X	L	L	X	X	X	L	L	L	L
	L	X	L	L	L	X	X	X	L	L	L	L
HOLD	H	L	L	L	L	X	X	X	QA0	QH0	QA0	QH0
SHIFT	H	L	H	L	L	$\downarrow$	X	H	H	QGn	H	QGn
RIGHT	H	L	H	L	L	$\downarrow$	X	L	L	QGn	L	QGn
SHIFT	H	H	L	L	L	$\downarrow$	H	X	QBn	H	QBn	H
LEFT	H	H	L	L	L	$\downarrow$	L	X	QBn	L	QBn	L
LOAD	H	H	H	X	X	$\downarrow$	X	X	a	h	a	h

\* When one or both output controls are high, the eight input/output terminals are in the high-impedance state ; however sequential or clearing of the register is not affected.

Z : High impedance

Qn0 : The level of Qn before the indicated steady-state input conditions were established.

Qnn : The level of Qn before the most recent active transition indicated by  $\downarrow$  or  $\uparrow$ .

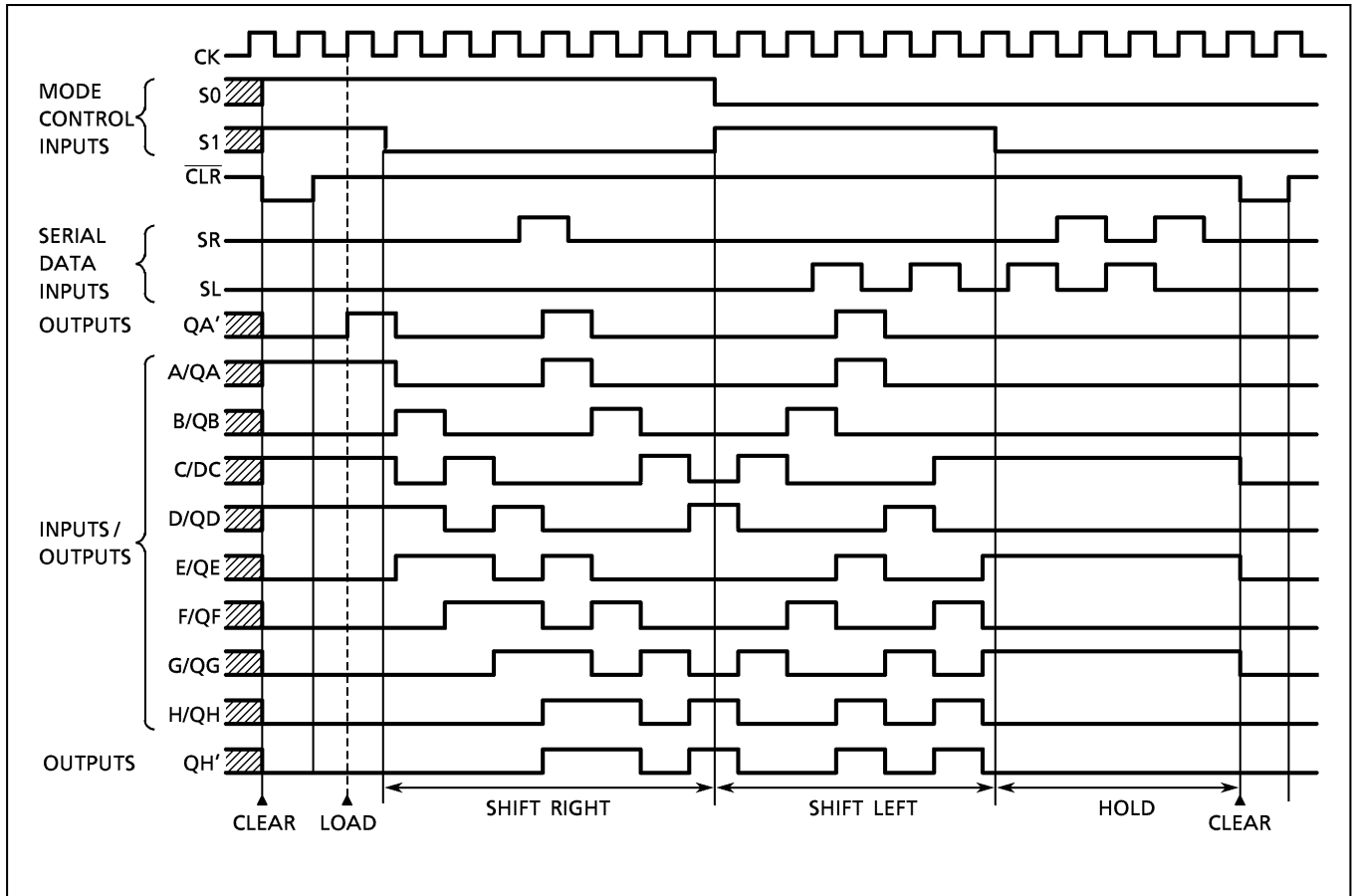
a, h : The level of the steady-state inputs A, H, respectively.

X : Don't Care.

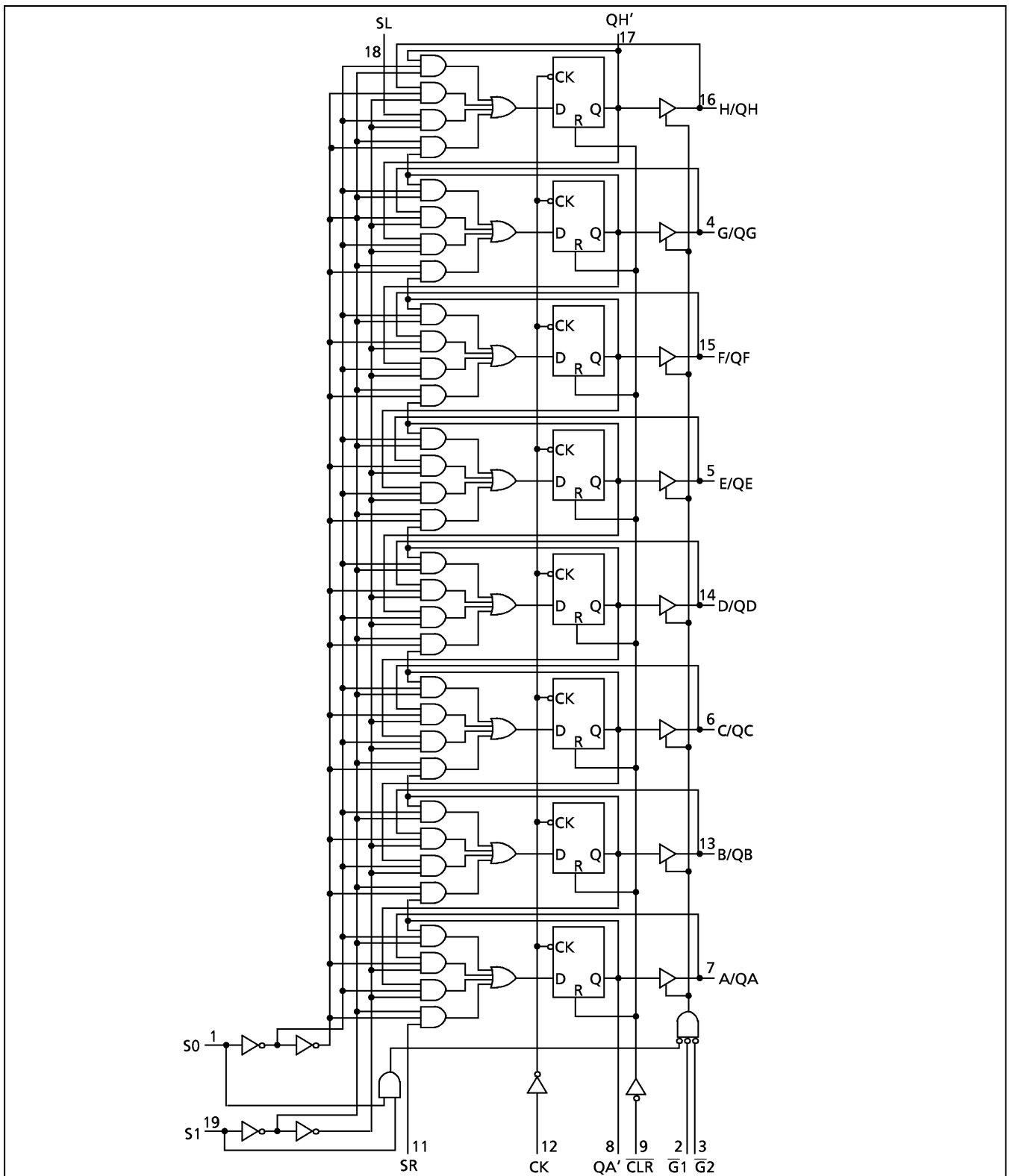
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TIMING CHART



SYSTEM DIAGRAM



## ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	$V_{CC}$	-0.5~7.0	V
DC Input Voltage	$V_{IN}$	-0.5~7.0	V
DC BUS I / O Voltage (A/QA~H/QH)	$V_{IN/OUT}$	-0.5~ $V_{CC} + 0.5$	V
DC Output Voltage (QA'~QH')	$V_{OUT}$	-0.5~ $V_{CC} + 0.5$	V
Input Diode Current	$I_{IK}$	-20	mA
Output Diode Current	$I_{OK}$	±20	mA
DC Output Current	$I_{OUT}$	±25	mA
DC $V_{CC}$ /Ground Current	$I_{CC}$	±80	mA
Power Dissipation	$P_D$	180	mW
Storage Temperature	$T_{stg}$	-65~150	°C

## RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	$V_{CC}$	2.0~5.5	V
Input Voltage	$V_{IN}$	0~5.5	V
DC BUS I / O Voltage (A/QA~H/QH)	$V_{IN/OUT}$	0~ $V_{CC}$	V
DC Output Voltage (QA'~QH')	$V_{OUT}$	0~ $V_{CC}$	V
Operating Temperature	$T_{opr}$	-40~85	°C
Input Rise and Fall Time	dt/dV	0~100 ( $V_{CC} = 3.3 \pm 0.3V$ ) 0~20 ( $V_{CC} = 5 \pm 0.5V$ )	ns/V

## DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITON		V <sub>CC</sub> (V)	Ta = 25°C			Ta = -40~85°C		UNIT
					MIN.	TYP.	MAX.	MIN.	MAX.	
High-Level Input Voltage	V <sub>IH</sub>			2.0 3.0~ 5.5	1.50 V <sub>CC</sub> ×0.7	— —	— —	1.50 V <sub>CC</sub> ×0.7	— —	V
Low-Level Input Voltage	V <sub>IL</sub>			2.0 3.0~ 5.5	— —	— —	0.50 V <sub>CC</sub> ×0.3	— —	0.50 V <sub>CC</sub> ×0.3	V
High-Level Output Voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50μA	2.0 3.0 4.5	1.9 2.9 4.4	2.0 3.0 4.5	— — —	1.9 2.9 4.4	— — —	V
			I <sub>OH</sub> = -4mA I <sub>OH</sub> = -8mA	3.0 4.5	2.58 3.94	— —	— —	2.48 3.80	— —	
Low-Level Output Voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 50μA	2.0 3.0 4.5	— — —	0.0 0.0 0.0	0.1 0.1 0.1	— — —	0.1 0.1 0.1	V
			I <sub>OL</sub> = 4mA I <sub>OL</sub> = 8mA	3.0 4.5	— —	— —	0.36 0.36	— —	0.44 0.44	
3-State Output Off-State Current	I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = V <sub>CC</sub> or GND		5.5	—	—	±0.25	—	±2.50	μA
Input Leakage Current	I <sub>IN</sub>	V <sub>IN</sub> = 5.5V or GND		0~5.5	—	—	±0.1	—	±1.0	
Quiescent Supply Current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	—	—	4.0	—	40.0	

AC ELECTRICAL CHARACTERISTICS (Input  $t_r = t_f = 3\text{ns}$ )

PARAMETER	SYMBOL	TEST CONDITION		Ta = 25°C			Ta = -40~85°C		UNIT
		V <sub>CC</sub> (V)	CL (pF)	MIN.	TYP.	MAX.	MIN.	MAX.	
Propagation Delay Time (CK-QA', QH')	t <sub>pLH</sub>	3.3 ± 0.3	15	—	12.2	17.2	1.0	19.8	ns
			50	—	14.7	20.7	1.0	23.3	
	5.0 ± 0.5	15	—	8.5	10.8	1.0	12.0		
		50	—	10.0	12.8	1.0	14.0		
Propagation Delay Time (CLR-QA', QH')	t <sub>pHL</sub>	3.3 ± 0.3	15	—	13.0	19.0	1.0	22.0	
			50	—	15.5	22.5	1.0	25.5	
	5.0 ± 0.5	15	—	9.1	11.2	1.0	13.5		
		50	—	10.8	13.2	1.0	15.5		
Propagation Delay Time (CK-QA~QH)	t <sub>pLH</sub>	3.3 ± 0.3	15	—	10.3	14.3	1.0	16.6	
			50	—	12.8	17.8	1.0	20.1	
	5.0 ± 0.5	15	—	7.3	9.1	1.0	10.4		
		50	—	8.8	11.1	1.0	12.4		
Propagation Delay Time (CLR-QA~QH)	t <sub>pHL</sub>	3.3 ± 0.3	15	—	10.8	17.0	1.0	19.5	
			50	—	13.3	20.5	1.0	23.0	
	5.0 ± 0.5	15	—	7.7	10.5	1.0	12.0		
		50	—	9.2	12.5	1.0	14.0		
Output Enable Time	t <sub>pZL</sub>	3.3 ± 0.3	15	—	13.3	16.5	1.0	19.2	
			50	—	14.8	19.0	1.0	21.7	
	5.0 ± 0.5	15	—	8.9	9.7	1.0	11.3		
		50	—	10.4	11.2	1.0	12.6		
Output Disable Time	t <sub>pLZ</sub>	3.3 ± 0.3	15	—	18.0	21.3	1.0	24.3	
			50	—	11.8	13.2	1.0	15.0	
Maximum Clock Frequency	f <sub>MAX</sub>	3.3 ± 0.3	15	100	65	—	55	—	
			50	90	55	—	50	—	
		5.0 ± 0.5	15	160	125	—	110	—	
			50	150	115	—	100	—	
Input Capacitance	C <sub>IN</sub>			—	4	10	—	pF	
BUS I/O Capacitance (A/QA~H/QH)	C <sub>OUT</sub>			—	8	—	—		
Power Dissipation Capacitance	C <sub>PD</sub>	(Note 1)		—	110	—	—		

Note (1) : C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation :

$$I_{CC(\text{opr})} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

TIMING REQUIREMENTS (Input  $t_r = t_f = 3ns$ )

PARAMETER	SYMBOL	TEST CONDITION	V <sub>CC</sub> (V)	Ta = 25°C		Ta = -40~85°C	UNIT
				TYP.	LIMIT	LIMIT	
Minimum Pulse Width (CK)	$t_{W(H)}$ $t_{W(L)}$		3.3 ± 0.3	—	7.0	8.0	ns
			5.0 ± 0.5	—	7.0	8.0	
Minimum Pulse Width ( $\overline{CLR}$ )	$t_{W(L)}$		3.3 ± 0.3 5.0 ± 0.5	— —	6.0 6.0	7.0 7.0	
Minimum Set-Up Time (SL, SR)	$t_s$		3.3 ± 0.3	—	8.5	10.0	
			5.0 ± 0.5	—	5.0	5.0	
Minimum Set-Up Time (A~H)	$t_s$		3.3 ± 0.3	—	8.0	9.0	
			5.0 ± 0.5	—	4.0	4.0	
Minimum Set-Up Time (S0, S1)	$t_s$		3.3 ± 0.3	—	14.5	17.0	
			5.0 ± 0.5	—	7.0	8.0	
Minimum Hold Time (SL, SR)	$t_h$		3.3 ± 0.3	—	1.0	1.0	
			5.0 ± 0.5	—	1.0	1.0	
Minimum Hold Time (A~H)	$t_h$		3.3 ± 0.3	—	0.5	0.5	
			5.0 ± 0.5	—	1.5	1.5	
Minimum Hold Time (S0, S1)	$t_h$		3.3 ± 0.3	—	0	0	
			5.0 ± 0.5	—	0.5	0.5	
Minimum Removal Time ( $\overline{CLR}$ )	$t_{rem}$		3.3 ± 0.3	—	5.0	6.0	
			5.0 ± 0.5	—	4.0	4.0	

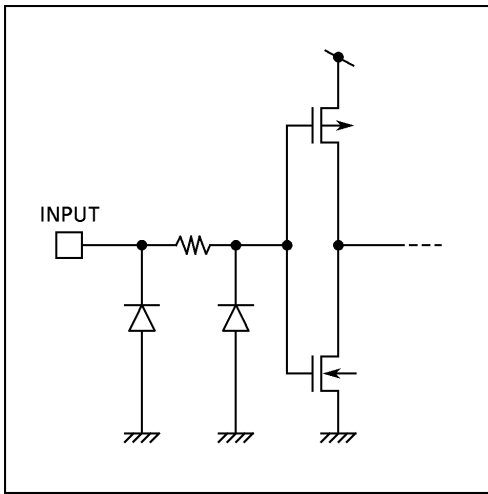
NOISE CHARACTERISTICS (Input  $t_r = t_f = 3ns$ )

PARAMETER	SYMBOL	TEST CONDITION	V <sub>CC</sub> (V)	Ta = 25°C		UNIT
				TYP.	LIMIT	
Quiet Output Maximum Dynamic V <sub>OL</sub>	V <sub>OLP</sub>	C <sub>L</sub> = 50pF	5.0	0.9 (1.0)	1.2 (1.4)	V
Quiet Output Minimum Dynamic V <sub>OL</sub>	V <sub>OLV</sub>	C <sub>L</sub> = 50pF	5.0	-0.9 (-1.0)	-1.2 (-1.4)	V
Minimum High Level Dynamic Input Voltage	V <sub>IHD</sub>	C <sub>L</sub> = 50pF	5.0	—	3.5	V
Maximum Low Level Dynamic Input Voltage	V <sub>ILD</sub>	C <sub>L</sub> = 50pF	5.0	—	1.5	V

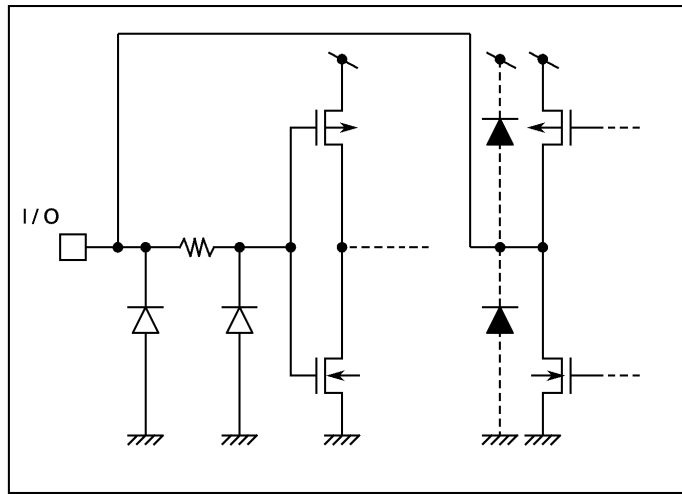
(Note) The value in ( ) only applies to JEDEC SOP (FW) devices.



**INPUT EQUIVALENT CIRCUIT**

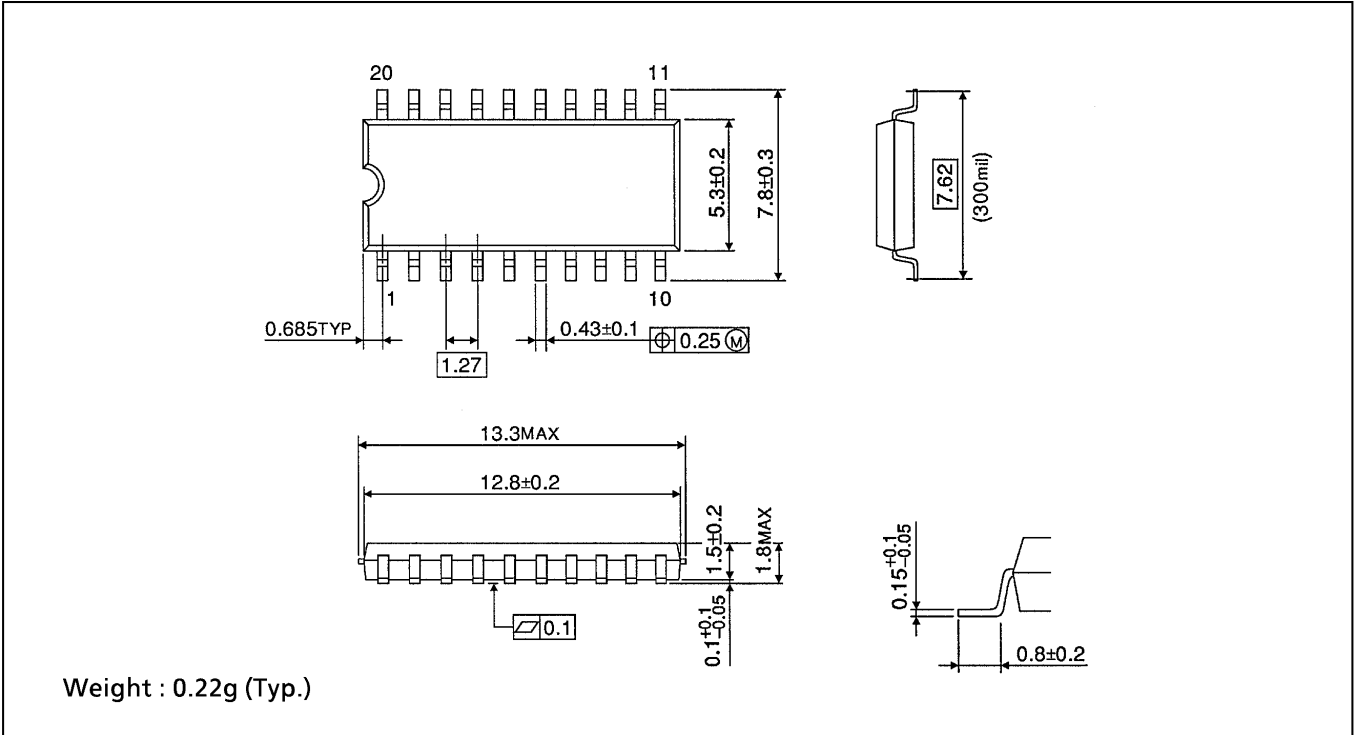


**A/QA~H/QH BUS TERMINAL EQUIVALENT CIRCUIT**



SOP 20PIN (200mil BODY) OUTLINE DRAWING (SOP20-P-300-1.27)

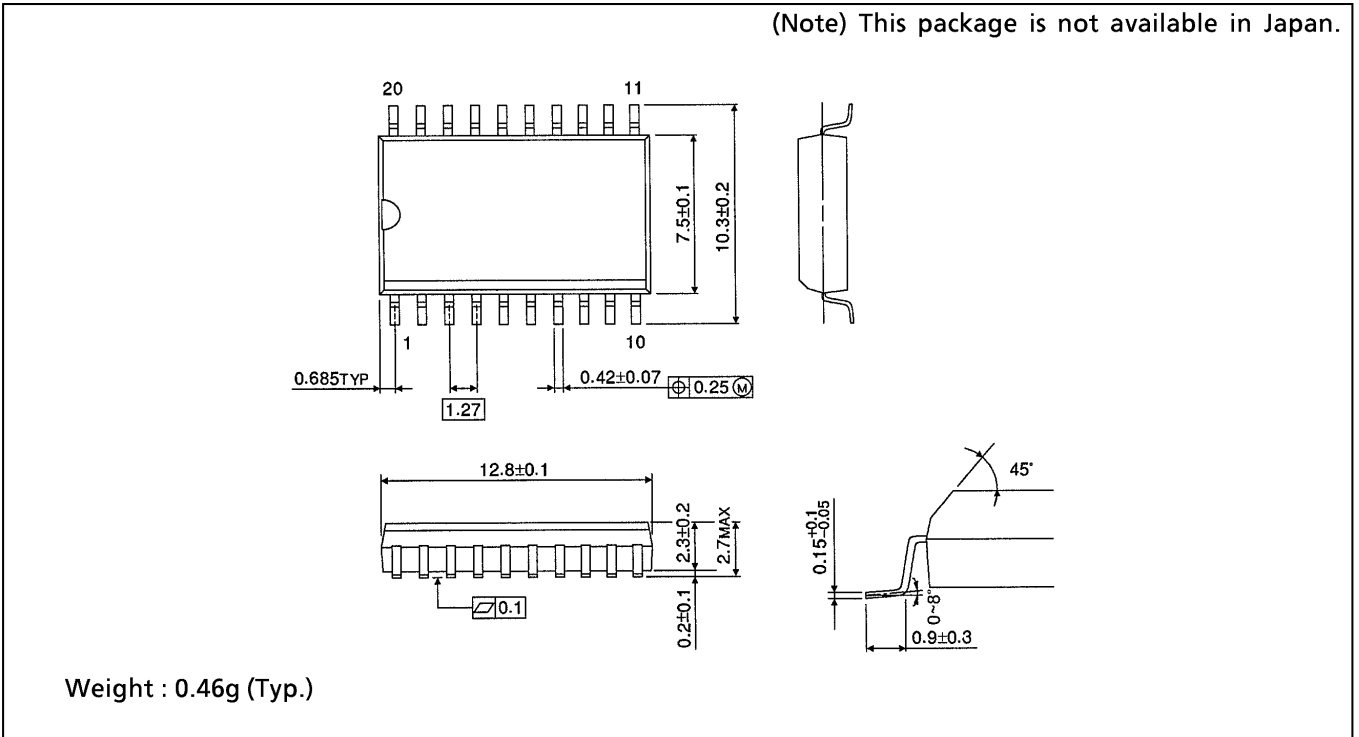
Unit in mm



SOP 20PIN (300mil BODY) OUTLINE DRAWING (SOP20-P-300-1.27)

Unit in mm

(Note) This package is not available in Japan.



**TSSOP 20PIN OUTLINE DRAWING (TSSOP20-P-0044-0.65)**

Unit in mm

